

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









March 2013

ח

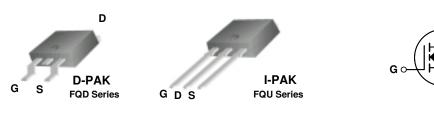
# FQD13N10L / FQU13N10L **N-Channel QFET MOSFET**

**100 V, 10 A, 180 m**Ω

### **Description**

This N-Channel enhancement mode power MOSFET is **Features** produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

- 10 A, 60 V,  $R_{DS(on)}$  = 180 m $\Omega$  (Max) @ $V_{GS}$  = 10 V,  $I_D = 5.0 A$
- Low Gate Charge (Typ. 8.7 nC)
- · Low Crss (Typ. 20 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating



## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD13N10L / FQU13N10L	Unit
$V_{DSS}$	Drain-Source Voltage		100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		10	Α
			6.3	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	40	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		95	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	10	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (I		4.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns
$P_{D}$	Power Dissipation (T <sub>A</sub> = 25°C) *  Power Dissipation (T <sub>C</sub> = 25°C)  - Derate above 25°C		2.5	W
			40	W
			0.32	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.13	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

<sup>\*</sup> When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	3	Min	Тур	Max	Unit
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
ΔBV <sub>DSS</sub> / ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C			0.09		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V				1	μА
		V <sub>DS</sub> = 80 V, T <sub>C</sub> = 125°C				10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
On Cha	racteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1.0		2.0	V
R <sub>DS(on)</sub>	Static Drain-Source $V_{GS} = 10 \text{ V}, I_D = 5.0 \text{ A}$				0.142	0.18	0
20(011)	On-Resistance	$V_{GS} = 5 \text{ V}, I_D = 5.0 \text{ A}$	_		0.158	0.2 Ω	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 5.0 \text{ A}$	(Note 4)		8.7		S
Dynami	ic Characteristics						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz			400	520	pF
C <sub>oss</sub>	Output Capacitance			-	95	125	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			I	20	25	pF
Switchi	ng Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_{D} = 12.8 \text{ A},$ $R_{G} = 25 \Omega$			7.5	25	ns
t <sub>r</sub>	Turn-On Rise Time				220	450	ns
t <sub>d(off)</sub>	Turn-Off Delay Time				22	55	ns
t <sub>f</sub>	Turn-Off Fall Time	_	(Note 4, 5)		72	150	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 80 V, I <sub>D</sub> = 12.8 A,			8.7	12	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{DS} = 60 \text{ V}, I_D = 12.6 \text{ A},$ $V_{GS} = 5 \text{ V}$ (Note 4, 5)			2.0		nC
Q <sub>gd</sub>	Gate-Drain Charge				5.3		nC
	-			I			
Drain-S	ource Diode Characteristics a	nd Maximum Rating	s				
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current		-		10	Α	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F	orward Current		1		40	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 10 \text{ A}$		-		1.5	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = 12.8 \text{ A},$			75		ns
^		-11 / -14 400 4/	(Note 4)				_

 $dI_F / dt = 100 A/\mu s$ 

(Note 4)

0.17

# $Q_{rr}$

- Notes: Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 1.43mH,  $I_{AS}$  = 10A,  $V_{DD}$  = 25V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $I_{SD}$  ≤ 12.8A,  $i_{J}$  d/id ≤ 300A/ $\mu$ s,  $V_{DD}$  ≤ 8 $V_{DS}$ , Starting  $T_{J}$  = 25°C 4. Pulse Test : Pulse width ≤ 300 $\mu$ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Reverse Recovery Charge

μС

# **Typical Characteristics**

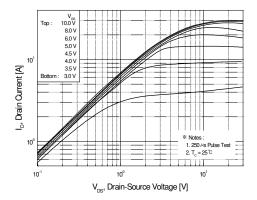


Figure 1. On-Region Characteristics

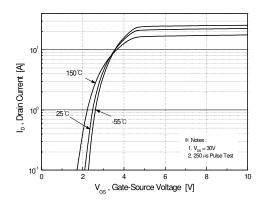


Figure 2. Transfer Characteristics

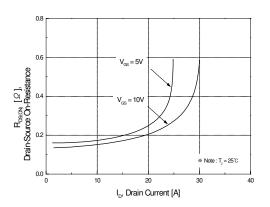


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

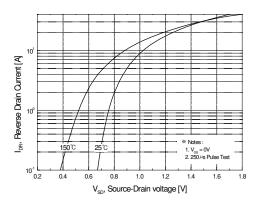


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

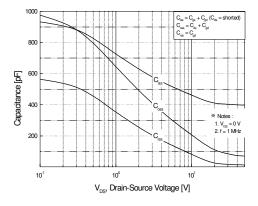


Figure 5. Capacitance Characteristics

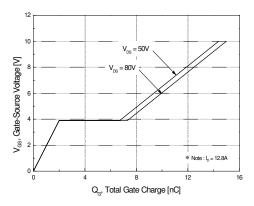


Figure 6. Gate Charge Characteristics

# 1.1 (Normalized) By RS. (Normalized) By RS. (Normalized) \* Notes: 1. V<sub>ce</sub> = 00 2. l<sub>p</sub> = 250 /A

-100

-50

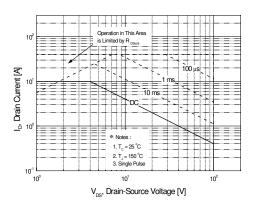
Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

 $T_J$ , Junction Temperature [°C]

150

Figure 8. On-Resistance Variation vs. Temperature



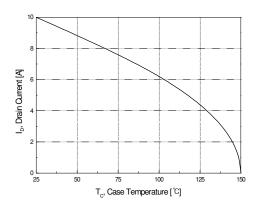


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

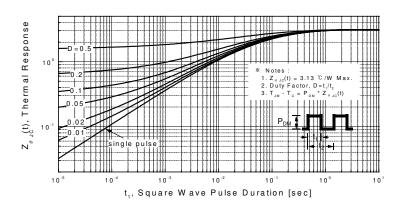
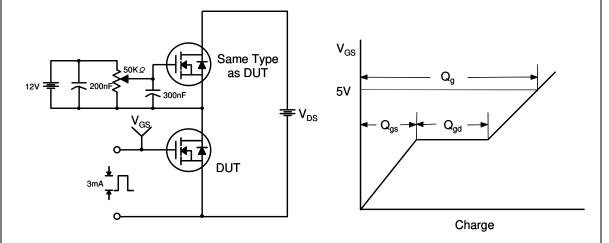
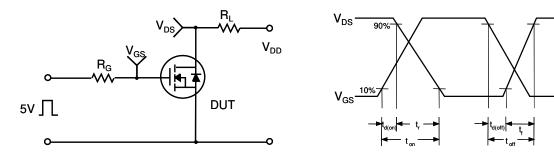


Figure 11. Transient Thermal Response Curve

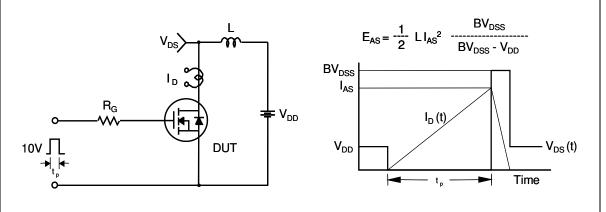
### **Gate Charge Test Circuit & Waveform**



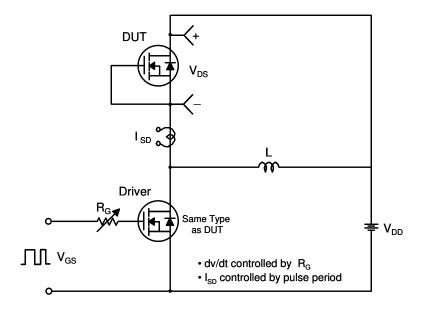
### **Resistive Switching Test Circuit & Waveforms**

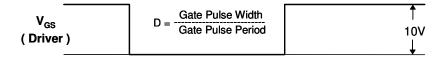


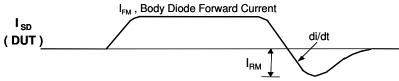
### **Unclamped Inductive Switching Test Circuit & Waveforms**



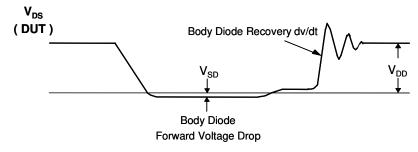
### Peak Diode Recovery dv/dt Test Circuit & Waveforms







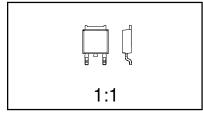
Body Diode Reverse Current



### **Package Dimensions**

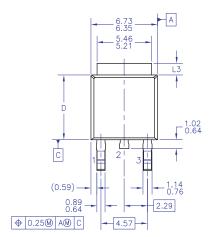
# TO-252 (DPAK) (FS PKG Code 36)

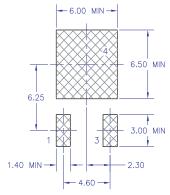




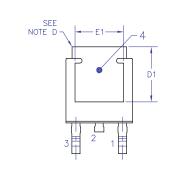
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

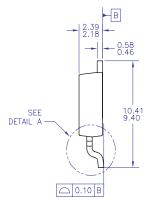
Part Weight per unit (gram): 0.33

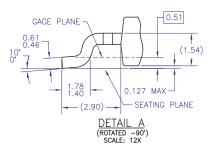




LAND PATTERN RECOMMENDATION





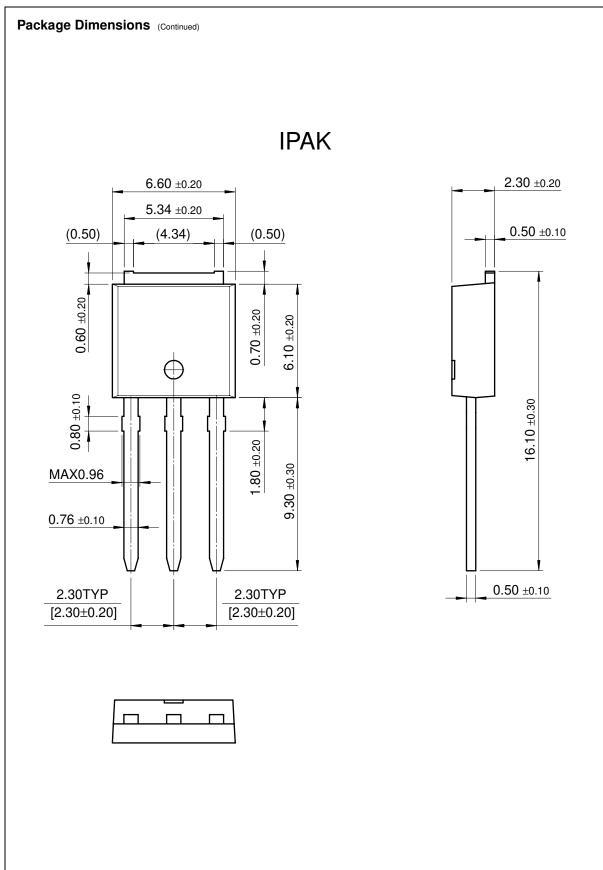


NOTES: UNLESS OTHERWISE SPECIFIED

- UNLESS OTHERWISE SPECIFIED
  ALL DIMENSIONS ARE IN MILLIMETERS.
  THIS PACKAGE CONFORMS TO JEDEC, TO-252,
  ISSUE C, VARIATION AA & AB, DATED NOV. 1999.
  DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-1994.
  HEAT SINK TOP EDGE COULD BE IN CHAMFERED
  CORNERS OR EDGE PROTRUSION.

- DIMENSIONS L3,D,E1&D1 TABLE:

	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN







### TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

2Cool™ AccuPower™ AX-CAP® BitSiC™ Build it Now™ CorePLUS™

CorePOWER™ CROSSVOLT™ CTL™ Current Transfer Logic™

DEUXPEED® Dual Cool™ EcoSPARK® EfficentMax™ ESBC™

Fairchild® Fairchild Semiconductor® FACT Quiet Series™ FACT<sup>®</sup>

FAST® FastvCore™ FETBench™ FPS™ F-PFS™ FRFET®

Global Power Resource<sup>SM</sup> Green Bridge™ Green FPS™ Green FPS™ e-Series™

Gmax™ GTO™ IntelliMAX™

ISOPLANAR™ Marking Small Speakers Sound Louder and Better™

MegaBuck™ MIČROCOUPLER™ MicroFET™ MicroPak™ MicroPak2™

MillerDrive™ MotionMax™ mWSaver™ OptoHiT™ OPTOLOGIC® OPTOPLANAR® PowerTrench® PowerXS™

Programmable Active Droop™ OFFT

QS™ Quiet Series™ RapidConfigure™

ng our world, 1mW/W/kW at a time™

SignalWise™ SmartMax™ SMART START™

Solutions for Your Success™

SPM® STEALTH™ SuperFET® SuperSOT™-3 SuperSOT™-6 SuperSOT™-8 SupreMOS® SyncFET™

Svnc-Lock™

SYSTEM®\* TinyBoost™ TinyBuck™ TinyCalc™ TinyLogic<sup>®</sup> TIŃYOPTO™ TinyPower™ TinyPWM™ TinyWire™

TranSiC<sup>®</sup> TriFault Detect™ TRUECURRENT®\* uSerDes™

**UHC®** Ultra FRFET™ UniFET™ **VCX™** VisualMax™ VoltagePlus™ XS™

\*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

**LIFE SUPPORT POLICY**FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

- Life support devices or systems are devices or systems which (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

### PRODUCT STATUS DEFINITIONS **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 164